High Power RSOA Chip



Part Number: CHP-286

High Power RSOA Chip Single-Mode RSOA Curved Waveguide Wavelength at 1550nm



Features

- High Output Power
- High Dynamic Range
- High Efficiency
- Standard RSOA Bare Die
- Cost Effective

Application

- OTDR
- Lidar
- Free Space Communications
- Network Test Equipment



SemiNex delivers the highest available power at infrared wavelengths between 12xx and 19xx nm. When necessary, we will further optimize the design of our InP & GaSb laser chips to meet our customers' specific optical and electrical performance needs. Diodes, bars, and packages are tested to meet customer and market performance demands. Typical results and packaging options are shown. Contact SemiNex for additional details or to discuss your specific requirements.



Specification

CHP-286



Optical	Symbol	Тур.	Units
Center Wavelength	λ_{c}	1550	nm
Aperture Width	AW	4	μm
Aperture Height	AH	1	μm
Beam Exit Angle	θεχτ	19.5	Degree
Noise Figure	NF	6	dB
Polarization Extinction Ratio	PER	18	dB
Fast Axis Div.	ΘT	30	Deg FWHM
Slow Axis Div.	ΘΙ	20	Deg FWHM
Front Facet Reflectivity	, , , , , , , , , , , , , , , , , , ,	<0.1%	
Rear Face Reflectivity		98%	
Waveguide		Curved	
Electrical			Units
Operating Current	I _{op}	1	A
Operating Voltage	V _{op}	2	V
Mechanical		Range	Units
Chip Length		2500	μm
Chip Width		500	μm
Operating Temp.**		-20 to 75	°C
Storage Temp.		-40 to 85	°C

Specified values are rated at a constant heat sink temperature of 20°C. **High temperature operation will reduce performance and MTTF.

Unless otherwise indicated all values are nominal.

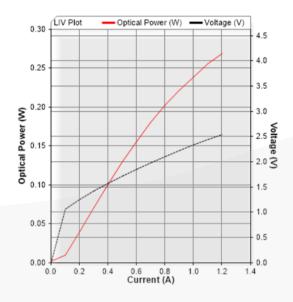
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SemiNex Laser Diodes CHP-286

Graphs & Data



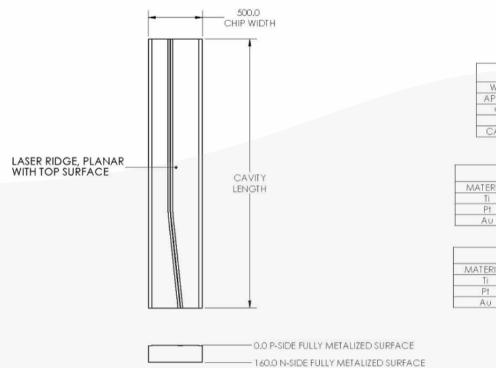


*Graphs and Data were collected from mounted parts

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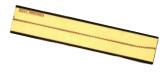


Mechanical Drawing



All statements, technical information and recommendations related to the product herein are based upon information
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4	DANGER
-	VISIBLE / INVISIBLE LASER RADIATION AVOID DIRECT EXPOSURE TO BEAM
1	CLASS IIIb and IV LASER PRODUCTS
1 1 1 1 1	This product complians with 21CFR1040 as applicable aser aperture is on the test station. Laser radiation from this product is considered an acute hazard to the with and even.



CHIP ATTRIBUTES			
WAVELENGTH	1550nm ±20nm		
APERTURE WIDTH	4µm±1µm		
CHIP WIDTH	0.500mm ±10µm		
THICKNESS	160µm±10µm		
CAVITY LENGTH	2.5mm ±10µm		

P-METAL				
MATERIAL	THICKNESS (nm)	TOLERANCE (nm)		
Ti	50	±10		
Pt	125	±25		
Au	250	±50		

N-METAL				
MATERIAL	THICKNESS (nm)	TOLERANCE (nm)		
Ti	30	±10		
Pt	125	±25		
Au	400	±40		